



JC511 U.S. \$10
09/512570

Class	Subclass	ISSUE CLASSIFICATION
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PATENT NUMBER

U.S. UTILITY Patent Application

R2W O.I.P.E. **PATENT DATE**
SCANNED  Q.A. 

APPLICATION NO. 09/512570	CONT/PRIOR	CLASS 428 250	SUBCLASS 55904	ART UNIT 2825 5574	EXAMINER JAN MOWAT
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EDWARD MCGRATH
DAVID PAUL

382. 199 ~~223~~ 2621 Tom Liu

Method for measurement of full-two dimensional submicron shapes

PTO-204
12/99

ISSUING CLASSIFICATION

TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.				NOTICE OF ALLOWANCE MAILED	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____ _____ _____				ISSUE FEE	
<input type="checkbox"/> The terminal ____ months of this patent have been disclaimed.				Amount Due	Date Paid
				ISSUE BATCH NUMBER	
				(Legal Instruments Examiner)	(Date)

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